

General Description

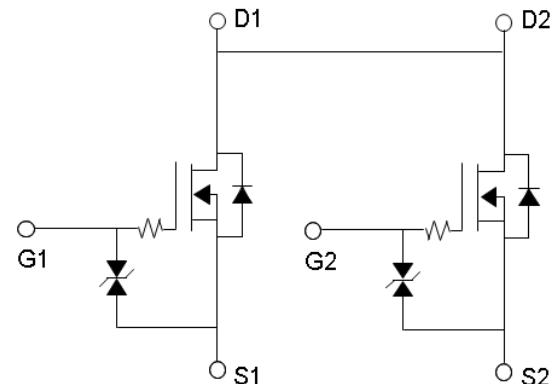
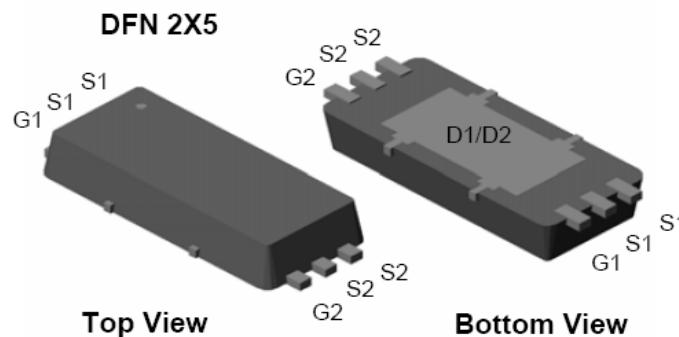
The MDA0336E uses advanced MagnaChip's MOSFET Technology, which provides high performance in on-state resistance, fast switching performance and excellent quality.

Features

- $V_{DS} = 20 \text{ V}$
- $I_D = 9 \text{ A}$
- Drain-Source ON Resistance;
 - $R_{DS(ON)} < 9.5\text{m}\Omega @ V_{GS} = 4.5\text{V}$
 - $R_{DS(ON)} < 10\text{m}\Omega @ V_{GS} = 4.0\text{V}$
 - $R_{DS(ON)} < 10.5\text{m}\Omega @ V_{GS} = 3.5\text{V}$
 - $R_{DS(ON)} < 11.5\text{m}\Omega @ V_{GS} = 3.1\text{V}$
- ESD Protection = HBM CLASS 2

Applications

- Portable Battery Protection Module



Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$ unless otherwise noted) Note 1

Characteristics	Symbol	Rating	Units
Drain-Source Voltage	V_{DSS}	20	V
Gate-Source Voltage	V_{GSS}	± 12	V
Continuous Drain Current	I_D	9	A
		7	A
Pulse Drain Current	I_{DM}	65	A
Power Dissipation for Single Operation	P_{DSM}	1.7	W
		1.0	
Junction and Storage Temperature Range	T_J, T_{stg}	-55~150	$^\circ\text{C}$

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal Resistance, Junction-to-Ambient(Steady-State)	$R_{\theta JA}$	75	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	6	

Ordering Information

Part Number	Temp. Range	Package	Packing	RoHS Status
MDA0336EURH	-55~150°C	2x5 DFN	Tape and Reel	Halogen Free

Electrical Characteristics (Ta =25°C unless otherwise noted)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Units
Static Characteristics						
Drain-Source Breakdown Voltage	BV _{DSS}	I _D = 250µA, V _{GS} = 0V	20	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250 uA	0.60	1.10	1.60	
Drain Cut-Off Current	I _{DSS}	V _{DS} = 20V, V _{GS} = 0V	-	-	1	uA
Gate Leakage Current	I _{GSS}	V _{GS} = ±10V, V _{DS} = 0V	-10.0	-	10.0	µA
Drain-Source Resistance ^{Note 2}	R _{DS(ON)}	V _{GS} = 4.5V, I _D = 9A	-	7.3	9.5	mΩ
		V _{GS} = 4.0V, I _D = 9A	-	7.5	10	
		V _{GS} = 3.5V, I _D = 9A	-	7.9	10.5	
		V _{GS} = 3.1V, I _D = 9A	-	8.4	11.5	
Forward Trans conductance	g _{fs}	V _{DS} = 5V, I _D = 9A	-	40	-	S
Dynamic Characteristics						
Total Gate Charge	Q _g	V _{DS} = 10V, I _D = 9A, V _{GS} = 4.5V	-	22	-	nC
Gate-Source Charge	Q _{gs}		-	3.7	-	
Gate-Drain Charge	Q _{gd}		-	10	-	
Input Capacitance	C _{iss}	V _{DS} = 10V, V _{GS} = 0V, f = 1MHz	-	1330	-	pF
Reverse Transfer Capacitance	C _{rss}		-	449	-	
Output Capacitance	C _{oss}		-	475	-	
Gate resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz	-	0.2	-	kΩ
Turn-On Delay Time	t _{d(on)}	V _{GS} = 4.5V, V _{DS} = 10V, R _L = 1.0Ω, R _{GEN} = 3Ω	-	1.0	-	us
Rise Time	t _r		-	0.15	-	
Turn-Off Delay Time	t _{d(off)}		-	0.3	-	
Fall Time	t _f		-	2.0	-	
Drain-Source Body Diode Characteristics						
Source-Drain Diode Forward Voltage	V _{SD}	I _S = 1.0A, V _{GS} = 0V	-	0.65	1	V
Body Diode Reverse Recovery Time	t _{rr}	I _F = 9A, di/dt = 200A/µs	-	30	-	ns
Body Diode Reverse Recovery Charge	Q _{rr}		-	25	-	nC

Notes :

- The device current rating is derived from its thermal resistance and from the number and diameter of bonding wires. The testing current at wafer level is set only for ease of testing. Actual package current ratings can be much higher.
- R_{DS(ON)} is Single MOS.

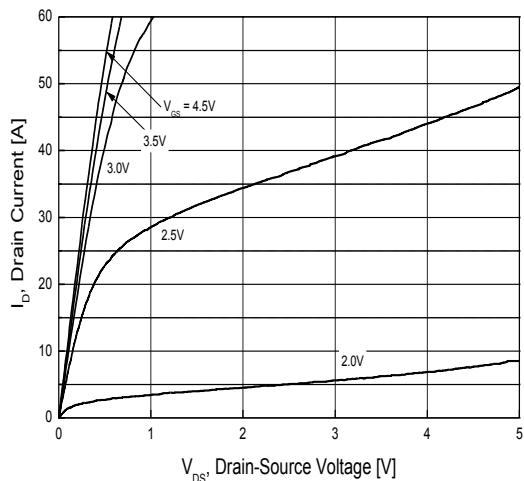


Fig.1 On-Region Characteristics

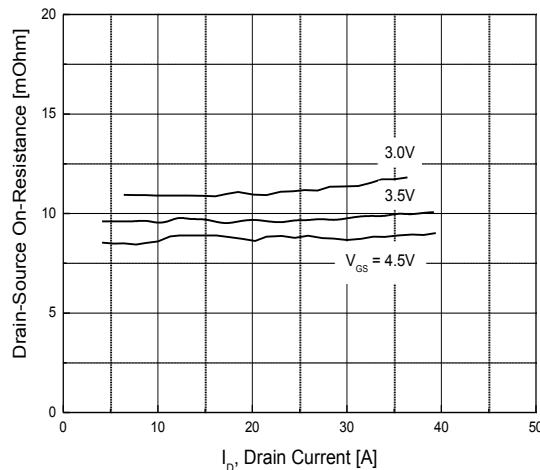


Fig.2 On-Resistance Variation with Drain Current and Gate Voltage

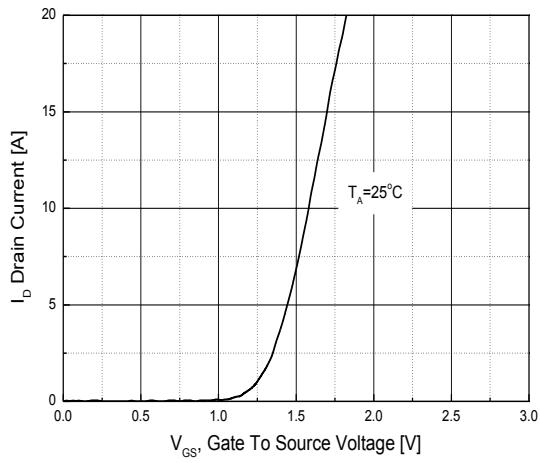


Fig.3 Transfer Characteristics

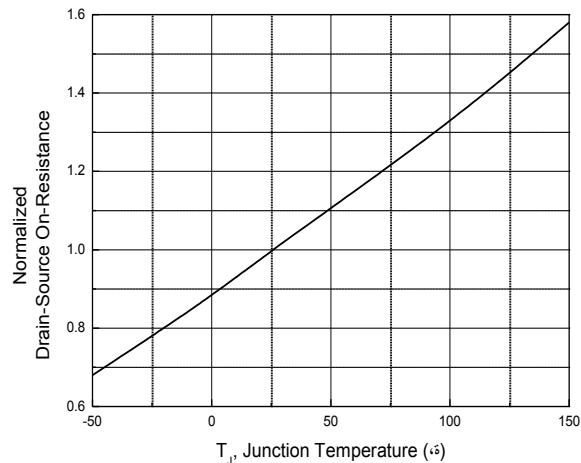


Fig.4 On-Resistance Variation with Temperature

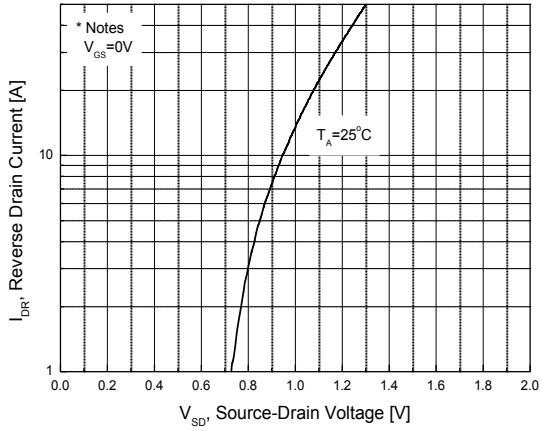


Fig.5 Body Diode Forward Voltage Variation with Source Current and Temperature

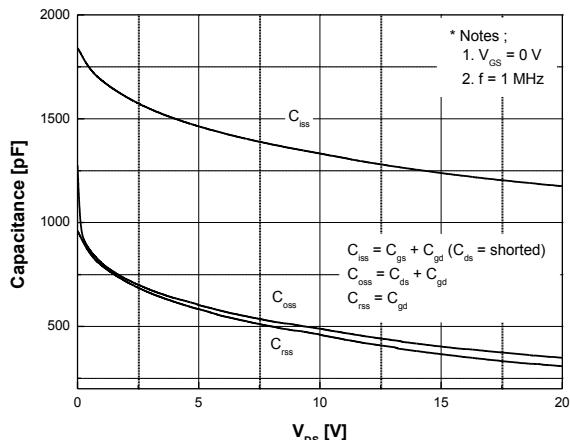


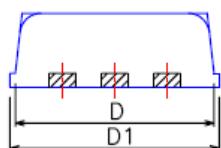
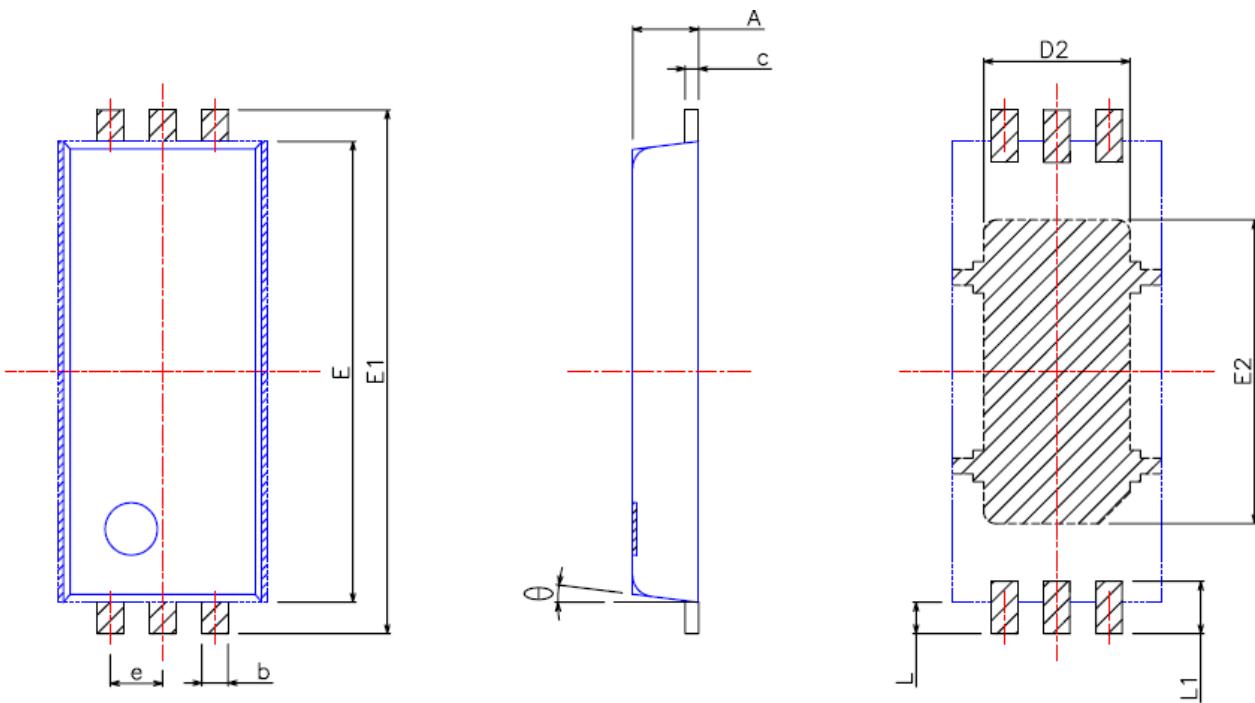
Fig.6 Capacitance Characteristics

Die Layout and Construction

Physical Dimensions

2x5mm, 6 Leads, DFN

Dimensions are in millimeters, unless otherwise specified



SYMBOL	MILLIMETERS			NOTE
	MINIMUM	NOMINAL	MAXIMUM	
A	0.63	0.65	0.67	
b	0.20	0.25	0.35	
c	0.10	0.13	0.20	
D	1.80	1.90	2.00	
D1	1.90	2.00	2.10	
D2	1.40 TYP			
E	4.30	4.40	4.50	
E1	4.90	5.00	5.10	
E2	2.90 TYP			
e	0.50 TYP			
L	0.20	0.30	0.40	
L1	0.35	0.50	0.65	
θ	2°	—	12°	

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